Application/Control No.	Α
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Applicant(s)/Patent	under
Reexamination	

10/052,521

Examiner

TANAKA, MITSUMASA

Art Unit

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SEARCHED				
Class	Subclass	Date	Examiner	
375	240.01	12/9/2004	МЈН	
375	240.15	12/22/2005	ER	
375	240.25	12/22/2005	ER	
386	52	12/22/2005	ER	
725	48	12/22/2005	ER	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

(INCLUDING SEARCH	STRATEGY	)
	DATE	EXMR
See Attached Search History Notes	12/9/2004	MJH
Keyword search	12/22/2005	ER
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